

SANYO Semiconductors DATA SHEET

An ON Semiconductor Company

2SC6095-

__ NPN Epitaxial Planar Silicon Transistor

High-Voltage Switching Applications

Applications

• DC / DC converter, relay drivers, lamp drivers, motor drivers, inverter.

Features

- · Adoption of FBET, MBIT process.
- · High current capacitance.
- · Low collector-to-emitter saturation voltage.
- · High-speed switching.
- · High allowable power dissipation.

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Collector-to-Base Voltage	VCBO		120	V
Collector-to-Emitter Voltage	VCES		120	V
Collector-to-Emitter Voltage	VCEO		80	V
Emitter-to-Base Voltage	VEBO		6.5	V
Collector Current	IC		2.5	Α
Collector Current (Pulse)	ICP		4	А
Base Current	IB		500	mA
Collector Dissipation	PC	Mounted on a ceramic board (250mm ² X0.8mm)	1.3	W
		Tc=25°C	3.5	W
Junction Temperature	Tj		150	°C
Storage Temperature	Tstg		-55 to +150	°C

Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Offic
Collector Cutoff Current	ІСВО	V _{CB} =70V, I _E =0A			1	μΑ
Emitter Cutoff Current	IEBO	V _{EB} =4V, I _C =0A			1	μΑ
DC Current Gain	hFE	V _{CE} =5V, I _C =100mA	300		600	

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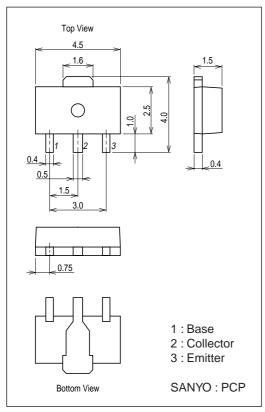
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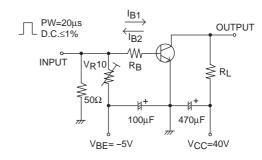
Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Oill
Gain-Bandwidth Product	fT	V _{CE} =10V, I _C =500mA		350		MHz
Output Capacitance	Cob	V _{CB} =10V, f=1MHz		14		pF
Collector-to-Emitter Saturation Voltage	VCE(sat)1	IC=1A, IB=50mA		100	150	mV
	VCE(sat)2	IC=1A, IB=100mA		90	135	mV
Base-to-Emitter Saturation Voltage	V _{BE} (sat)	I _C =1A, I _B =100mA		0.9	1.2	V
Collector-to-Base Breakdown Voltage	V(BR)CBO	IC=10μA, IE=0A	120			V
Collector-to-Emitter Breakdown Voltage	V(BR)CES	I _C =100μA, R _{BE} =0Ω	120			V
Collector-to-Emitter Breakdown Voltage	V(BR)CEO	IC=1mA, RBE=∞	80			V
Emitter-to-Base Breakdown Voltage	V(BR)EBO	IE=10μA, IC=0A	6.5			V
Turn-ON Time	ton	See specified Test Circuit.		40		ns
Storage Time	tstg	See specified Test Circuit.		920		ns
Fall Time	tf	See specified Test Circuit.		32		ns

Package Dimensions

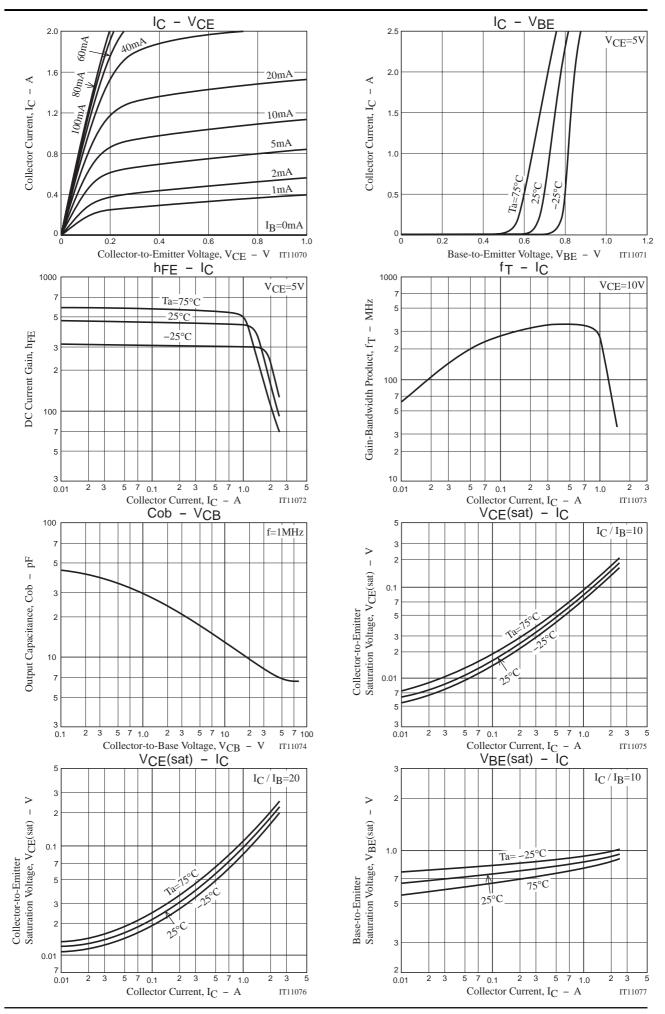
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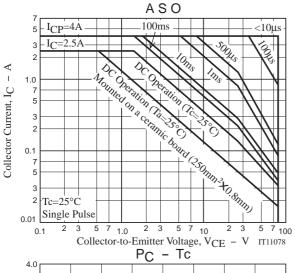
Switching Time Test Circuit

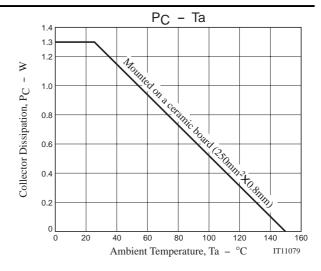


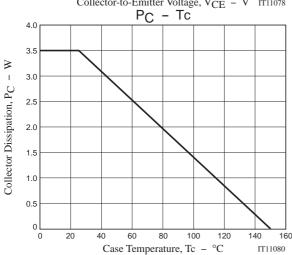
 $10I_{B1} = -10I_{B2} = I_{C} = 0.5A$



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